

<b>Notice of References Cited</b>	Application/Control No. 10/549,755		Applicant(s)/Patent Under Reexamination YAMADA ET AL.	
	Examiner SHEWANA SKINNER		Art Unit 3689	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0059182	05-2002	Oka et al.	707/1
*	B	US-2002/0120489	08-2002	Matsuda et al.	705/9
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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